

Electronic Supplementary Information for

Nanoimprint lithography of nanoporous carbon materials for micro-supercapacitor architectures

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S.1. Methods

Leakage current calculation

Leakage current is calculated measuring the self-discharge in open circuit after pre-charging the micro-EDLC to 1 V. The corresponding leakage current was estimated using the following equation:

$$I_{\text{leak}} = C \cdot \frac{dV}{dt} \quad (1)$$

Where I_{leak} is the leakage current, C is the capacitance obtained from the CV curves dV/dt is the discharge rate.

Energy and Power Densities

The electrochemical performance of the micro-EDLC devices was based on galvanostatic charge-discharge measurements. The volumetric energy density ($E_{\text{vol.}}$) was obtained from equation (2):

$$E_{\text{vol.}} = \frac{A_{\text{dis}} \cdot I}{V_{\text{IDE}} \cdot 3600} \quad (2)$$

where $A_{\text{dis.}}$ is the area of the integrated discharge curve and I the applied current. V_{IDE} is the complete volume of the interdigital electrodes.

The Volumetric power density (P) is calculated from the energy density ($E_{\text{vol.}}$) and the discharge time t_{dis} :

$$P_{\text{vol.}} = \frac{E_{\text{vol.}}}{t_{\text{dis}}} \quad (3)$$

S.2. Supplementary Figures

S.1

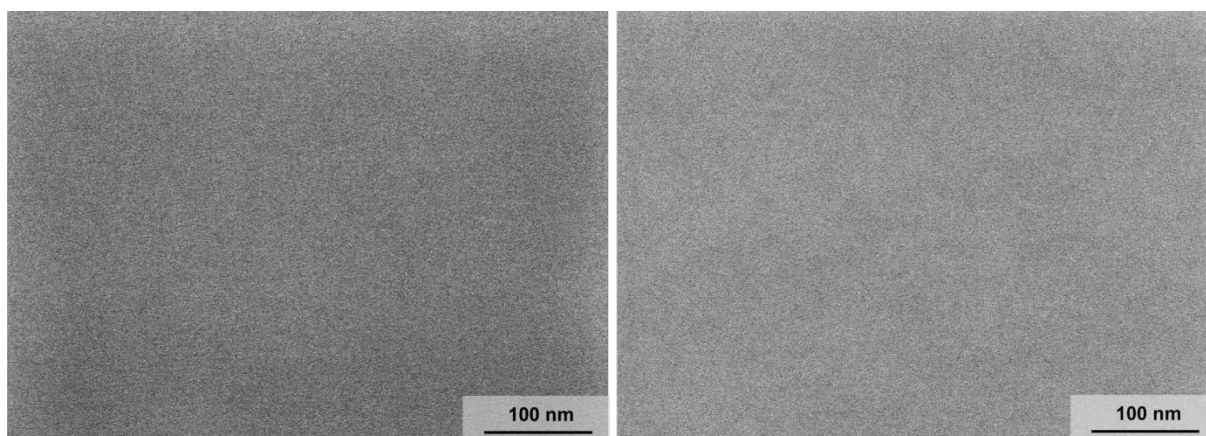


Figure S.1 - SEM images of a C_F pyrolyzed at 900 °C (left) and an AC_F-30 (right).

S.2

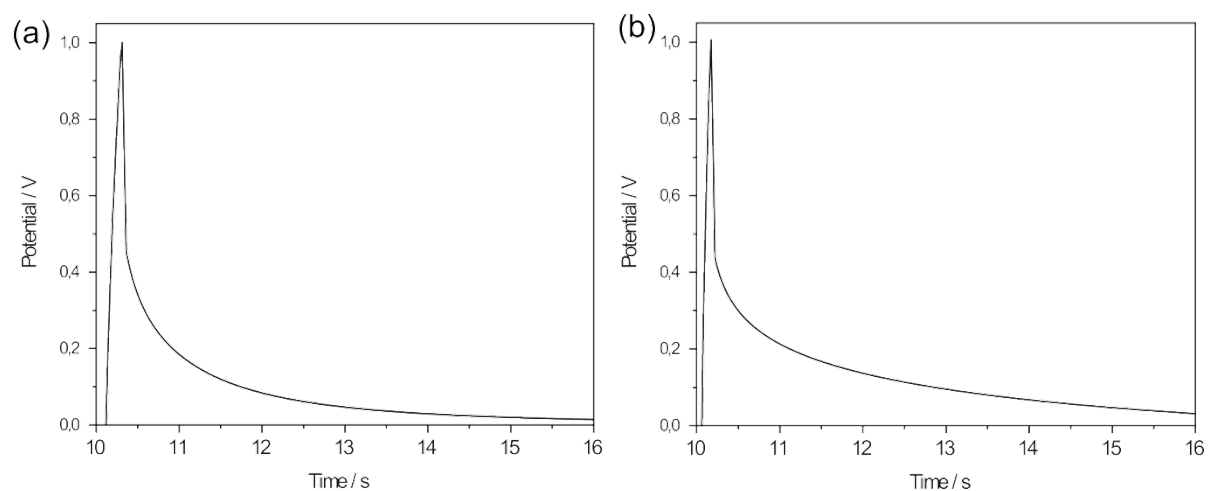


Figure S.2 – Galvanostatic charge/discharge curves of C_{IDE-0,5} (a) and N-C_{IDE-0,5} (b) measured with a current density of 1 mA cm⁻².

S.3

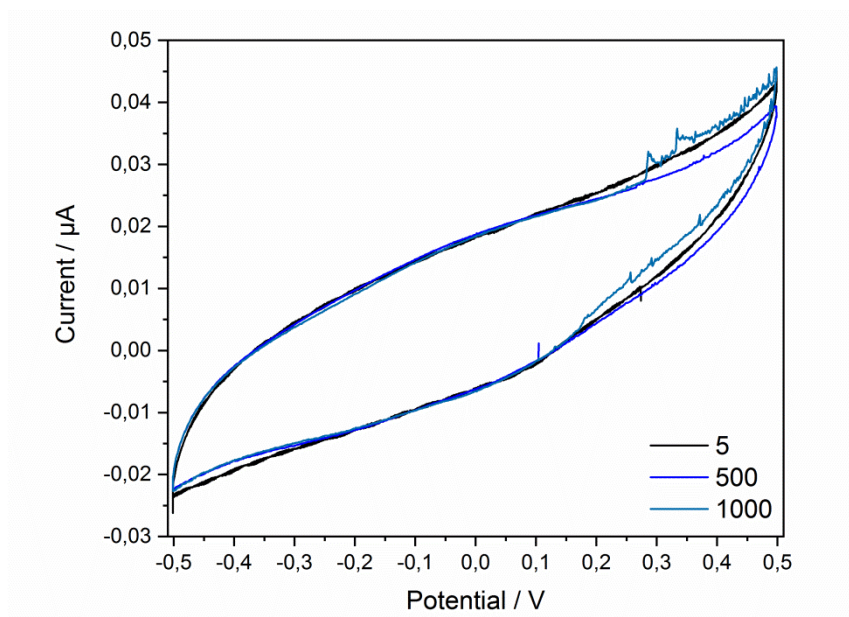


Figure S.3 – Cyclic voltammograms of N-C_{IDE-0,5} at different cycle numbers (5; 500; 1000) measured at a scan rate of 10 mV s⁻¹.

S.4

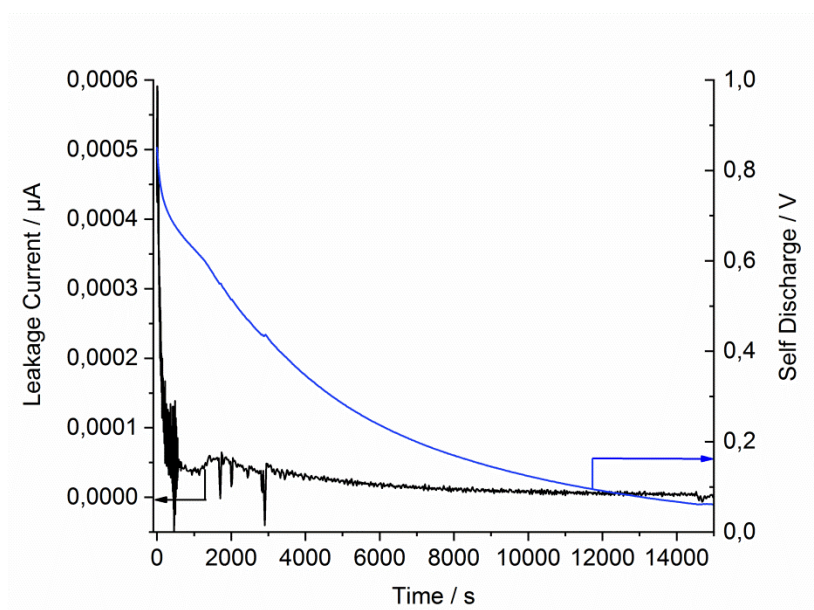


Figure S.4 – Leakage current and self-discharge characteristics of a N-C_{IDE-0,5} after charging to 1 V and measuring the self-discharge at open circuit.

At the beginning a high leakage current is observed. After 4.000 seconds the current regulates to a constant value of $1,5 \cdot 10^{-5} \mu\text{A}$. The leakage current is probably caused by residual carbon between the lines of the two electrodes. An increase of the spacing between the fingers could reduce these effects.